

| L Number | Hits | Search Text | DB | Time stamp |
|----------|------|---|---|------------------|
| 6 | 0 | (contour adj graph) same search\$3 same retriev\$3 same word | USPAT; EPO; JPO; DERWENT; IBM_TDB | 2004/02/20 11:29 |
| 7 | 3 | GRAPH SAME DOCUMENT SAME CONCEPT SAME INTEREST | USPÄT; EPO; JPO; DERWENT; IBM_TDB | 2004/02/20 11:30 |
| 8 | 0 | (concept same interest) same thumbprint | USPÄT; EPO; JPO; DERWENT; IBM_TDB | 2004/02/20 11:31 |
| 9 | 111 | (contour adj graph) | USPÄT; EPO; JPO; DERWENT; IBM_TDB | 2004/02/20 11:31 |
| 10 | 0 | ((contour adj graph)) same keyword | USPÄT; EPO; JPO; DERWENT; IBM_TDB | 2004/02/20 11:31 |
| 11 | 0 | ((contour adj graph)) same kwic | USPÄT; EPO; JPO; DERWENT; IBM_TDB | 2004/02/20 11:31 |
| 1 | 322 | 715/500.ccls. | USPÄT | 2004/02/20 11:32 |
| 2 | 744 | 715/529-531.ccls. | USPAT | 2004/02/20 11:35 |
| 3 | 634 | 345/440.ccls. | USPAT | 2004/02/20 11:36 |
| 4 | 181 | 345/684.ccls. | USPAT | 2004/02/20 11:39 |
| 5 | 9 | 345/689.ccls. | USPAT | 2004/02/20 11:39 |
| - | 0 | graph same location same concentration same kwic | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/19 16:07 |
| - | 0 | graph same location same concentration same keyword | USPÄT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/19 16:21 |
| - | 7 | graph same location same distribution same text | USPÄT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/19 16:23 |
| - | 14 | histogram same location same distribution same text | USPÄT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/19 16:24 |
| - | 1 | ("5339391").PN. | USPÄT; US-PGPUB; EPO; JPO; IBM_TDB | 2004/02/20 07:07 |

| | Document ID | Issue Date | Title | Current OR | Inventor | Image Doc. Displayed | PT |
|---|-------------------|------------|---|------------|-------------------------------------|----------------------|--------------------------|
| 1 | US 20030076989 A1 | 20030424 | Automated repetitive array microstructure defect inspection | 382/145 | Maayah, Kais Jameel et al. | US 20030076989 | <input type="checkbox"/> |
| 2 | US 20020131651 A1 | 20020919 | System and method for reducing images including graphs | 382/284 | Anantharamu, Chandrashekhara et al. | US 20020131651 | <input type="checkbox"/> |
| 3 | US 20010049671 A1 | 20011206 | e-Stract: a process for knowledge-based retrieval of electronic information | 706/50 | Joerg, Werner B. | US 20010049671 | <input type="checkbox"/> |
| 4 | US 6691259 B1 | 20040210 | Terminal server data file extraction and analysis application | 714/46 | Mackey, Kyle Joseph James et al. | US 6691259 | <input type="checkbox"/> |
| 5 | US 6567767 B1 | 20030520 | Terminal server simulated client performance measurement tool | 702/186 | Mackey, Kyle Joseph James et al. | US 6567767 | <input type="checkbox"/> |
| 6 | US 5867597 A | 19990202 | High-speed retrieval by example | 382/209 | Peairs, Mark et al. | US 5867597 | <input type="checkbox"/> |
| 7 | NN7208834 | 19720801 | Computer Generation of 3D Pictures. August 1972. | | | NN7208834 | <input type="checkbox"/> |

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|---|-------------------------|------------|---|------------|------------------------------|----------------------|--------------------------|
| 1 | US 20030076989 A1 | 20030424 | Automated repetitive array microstructure defect inspection | 382/145 | Maayah, Kais Jameel et al. | US 20030076989 | <input type="checkbox"/> |
| 2 | US 20030049653 A1 | 20030313 | Method for serial analysis of gene expression | 435/6 | Kinzler, Kenneth W. et al. | US 20030049653 | <input type="checkbox"/> |
| 3 | US 20030008290 A1 | 20030109 | Serial analysis of transcript expression using long tags | 435/6 | Velculescu, Victor E. et al. | US 20030008290 | <input type="checkbox"/> |
| 4 | US 6565003 B1 | 20030520 | Method for locating and reading a two-dimensional barcode | 235/462.1 | Ma, Yue | US 6565003 | <input type="checkbox"/> |
| 5 | US 6498013 B1 | 20021224 | Serial analysis of transcript expression using MmeI and long tags | 435/6 | Velculescu, Victor E. et al. | US 6498013 | <input type="checkbox"/> |
| 6 | US 6383743 B1 | 20020507 | Method for serial analysis of gene expression | 435/6 | Kinzler, Kenneth W. et al. | US 6383743 | <input type="checkbox"/> |
| 7 | US 6082619 A | 20000704 | Method for locating and reading a two-dimensional barcode | 235/462.1 | Ma, Yue et al. | US 6082619 | <input type="checkbox"/> |
| 8 | US 5867597 A | 19990202 | High-speed retrieval by example | 382/209 | Peairs, Mark et al. | US 5867597 | <input type="checkbox"/> |
| 9 | US 5866330 A | 19990202 | Method for serial analysis of gene expression | 435/6 | Kinzler, Kenneth W. et al. | US 5866330 | <input type="checkbox"/> |

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|----|--------------|------------|---|------------|------------------------|----------------------|--------------------------|
| 10 | US 5828771 A | 19981027 | Method and article of manufacture for determining whether a scanned image is an original image or fax image | 382/112 | Bloomberg, Dan S. | US 5828771 | <input type="checkbox"/> |
| 11 | US 5425110 A | 19950613 | Method and apparatus for automatic language determination of Asian language documents | 382/192 | Spitz, A. Lawrence | US 5425110 | <input type="checkbox"/> |
| 12 | US 5257206 A | 19931026 | Statistical process control for air separation process | 700/273 | Hanson, Thomas C. | US 5257206 | <input type="checkbox"/> |
| 13 | US 4656665 A | 19870407 | Thresholding technique for graphics images using histogram analysis | 382/172 | Pennebaker, William B. | US 4656665 | <input type="checkbox"/> |
| 14 | NN8804405 | 19880401 | Automated Inspection Microscope | | | NN8804405 | <input type="checkbox"/> |